Search Notes		
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Application No.	Applicant(s)	
10/038,084	FALSTER, ROBERT	J.
Examin r	Art Unit	
Anh D. Mai	2814	

Class	T		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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EAST (all): * CZ and wafer and vacancy and defect	1/15/2004	A.M